



## Reliability block diagrams



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  - Professionals Australia
  - Risk Management Institution
  - The University of New South Wales
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- 

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Australian Standard®

## Reliability block diagrams

Originated as AS IEC 61078—2008.  
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## PREFACE

This Standard was prepared by the Standards Australia Committee QR-005, Dependability, to supersede AS IEC 61078—2008, *Analysis techniques for system reliability—Reliability block diagram and Boolean methods*.

The objective of this Standard is to describe the requirements that apply when reliability block diagrams (RBDs) are used in dependability analysis. It also describes the procedures for modelling the dependability of a system with RBDs. This Standard includes guidance on other methods of analysis and describes the relationships between RBDs and fault tree analysis and Markov techniques.

This Standard is identical with, and has been reproduced from IEC 61078:2016 (Ed. 3.0), *Reliability block diagrams*.

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The term ‘informative’ has been used in this Standard to define the application of the annex to which it applies. An ‘informative’ annex is only for information and guidance.

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## INTRODUCTION

A reliability block diagram (RBD) is a pictorial representation of a system's successful functioning. It shows the logical connection of (functioning) components (represented by blocks) needed for successful operation of the system (hereafter referred to as "system success"). Therefore an RBD is equivalent to a logical equation of Boolean variables and the probabilistic calculations are primarily related to constant values of the block success/failure probabilities.

Many different analytical methods of dependability analysis are available, of which the RBD is one. Therefore, the purpose of each method and their individual or combined applicability in evaluating the availability, reliability, failure frequency and other dependability measures as may be applicable to a given system or component should be examined by the analyst prior to deciding to use the RBD. Consideration should also be given to the results obtainable from each method, data required to perform the analysis, complexity of analysis and other factors identified in this standard.

Provided that the blocks in the RBD behave independently from each other and that the order in which failures occur does not matter then the probabilistic calculations can be extended to time dependent probabilistic calculations involving non-repaired as well as repaired blocks (e.g. blocks representing non-repaired or repaired components). In this case three dependability measures related to the system successful functioning have to be considered: the reliability itself,  $R_S(t)$ , but also the availability,  $A_S(t)$  and the failure frequency,  $w_S(t)$ . While, for systems involving repaired components, the calculations of  $A_S(t)$  or  $w_S(t)$  can be done quite straightforwardly, the calculation of  $R_S(t)$  implies systemic dependencies (see definition 3.34) which cannot be taken into account within the mathematical framework of RBDs. Nevertheless, in particular cases, approximations of  $R_S(t)$  are available.

The RBD technique is linked to fault tree analysis [1]<sup>1</sup> and to Markov techniques [2]:

- The underlying mathematics is the same for RBDs and fault tree analysis (FTA): when an RBD is focused on system success, the FT is focused on system failure. It is always possible to transform an RBD into an FT and vice versa. From a mathematical point of view, RBD and FT models share dual logical expressions. Therefore, the mathematical developments and the limitations are similar in both cases.
- When the availability  $A_i(t)$  of one block can be calculated by using an individual Markov process [2] independent of the other blocks, this availability,  $A_i(t)$ , can be used as input for the calculations related to an RBD including this block. This approach where an RBD provides the logic structure and Markov processes numerical values of the availabilities of the blocks is called "RBD driven Markov processes".

For systems where the order of failures is to be taken into account, or where the repaired blocks do not behave independently from each other or where the system reliability,  $R_S(t)$ , cannot be calculated by analytical methods, Monte Carlo simulation or other modelling techniques, such as dynamic RBDs, Markov [2] or Petri net techniques [3], may be more suitable.

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<sup>1</sup> Numbers in square brackets refer to the Bibliography.

## AUSTRALIAN STANDARD

**Reliability block diagrams****1 Scope**

This International Standard describes:

- the requirements to apply when reliability block diagrams (RBDs) are used in dependability analysis;
- the procedures for modelling the dependability of a system with reliability block diagrams;
- how to use RBDs for qualitative and quantitative analysis;
- the procedures for using the RBD model to calculate availability, failure frequency and reliability measures for different types of systems with constant (or time dependent) probabilities of blocks success/failure, and for non-repaired blocks or repaired blocks;
- some theoretical aspects and limitations in performing calculations for availability, failure frequency and reliability measures;
- the relationships with fault tree analysis (see IEC 61025 [1]) and Markov techniques (see IEC 61165 [2]).

**2 Normative references**

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050-192, *International Electrotechnical Vocabulary – Part 192: Dependability* (available at <http://www.electropedia.org>)

IEC 61703, *Mathematical expressions for reliability, availability, maintainability and maintenance support terms*

**3 Terms and definitions**

For the purposes of this document, the terms and definitions given in IEC 60050-192 as well as the following apply.

NOTE Some terms have been taken from IEC 60050-192 and modified for the needs of this standard.

**3.1****reliability block diagram****RBD**

logical, graphical representation of a system showing how the success states of its sub-items (represented by blocks) and combinations thereof, affect system success state

Note 1 to entry: The RBD technique was developed a long time ago when the term “reliability” was used as an umbrella term for “successful functioning”. This umbrella term is now superseded by “dependability”. Nevertheless it is still in use in the vernacular language and terms like “reliability engineering”, “reliability studies” or “reliability block diagram”. Therefore the term “reliability” used in RBD does not mean that this technique allows to calculate the reliability of a complex system straightforwardly from reliabilities of its constituting blocks (see 10.3.1.4).

Note 2 to entry: An RBD is a directed acyclic graph (i.e. a graph without loops) representing the logical links between the success state of a system and the success states of its constituting blocks. This logical architecture is mainly represented by conventional series and parallel graphical structures (see Clause 4 and Clause 7).